

Search Notes

Application/Control No.

10/608,567

Examiner

James J. Debrow

Applicant(s)/Patent under
Reexamination

OHASHI ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	517	2/2/2006	JD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search	2/1/2006	JD
search related cases	2/1/2006	JD
US-PGPUB; USPAT; JPO;DERWENT	2/1/2006	JD
ACM Digital Library (see search notes)	2/2/2006	JD